


<b>Search Notes</b> 	<b>Application/Control No.</b> 10551514	<b>Applicant(s)/Patent Under Reexamination</b> VAN DER WIEL, APPOLONIUS H. JACOBUS
	<b>Examiner</b> Hsien-ming Lee	<b>Art Unit</b> 2823

SEARCHED			
Class	Subclass	Date	Examiner
438	25,26,55	4/30/09	HL
73	861.355,861.356,861.357	4/30/09	HL

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (USPAT, USPG, USOCR, EPO, JPO, IBM, Derwent)	4/30/09	HL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

	/Hsien-ming Lee/ Primary Examiner.Art Unit 2823
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